Description

The VST12N048 uses **Super Trench** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Q_g. This device is ideal for high-frequency switching and synchronous rectification.
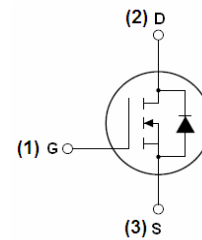
General Features

- V_{DS} =120V, I_D =129A

  $R_{DS(ON)}$ <5.3mΩ @ V_{GS}=10V
- Excellent gate charge x $R_{DS(on)}$ product
- Very low on-resistance $R_{DS(on)}$
- 175 °C operating temperature
- Pb-free lead plating
- 100% UIS tested

Application

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification

TO-263

Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VST12N048-T3	VST12N048	TO-263	-	-	-

Absolute Maximum Ratings (T_C=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	120	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current-Continuous	I_D	129	A
Drain Current-Continuous(T_C=100℃)	I_D (100℃)	92	A
Pulsed Drain Current	I_{DM}	480	A
Maximum Power Dissipation	P_D	185	W
Derating factor		1.3	W/℃
Single pulse avalanche energy [Note 5]	E_{AS}	1000	mJ
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 175	℃

Thermal Characteristic

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Thermal Resistance,Junction-to-Case[Note 2]	$R_{\theta JC}$	0.8	℃/W

Electrical Characteristics (T_C=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}=0V I_D=250μA	120		-	V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS}=120V,V_{GS}=0V	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	V_{GS}=±20V,V_{DS}=0V	-	-	±100	nA
On Characteristics [Note 3]						
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}=V_{GS},I_D=250μA	2.5	3.3	4.5	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	V_{GS}=10V, I_D=60A	-	4.8	5.3	mΩ
Forward Transconductance	g_{FS}	V_{DS}=10V,I_D=60A	60	-	-	S
Dynamic Characteristics [Note4]						
Input Capacitance	C_{Iss}	V_{DS}=50V,V_{GS}=0V, F=1.0MHz	-	5600	-	PF
Output Capacitance	C_{oss}		-	641	-	PF
Reverse Transfer Capacitance	C_{rss}		-	28	-	PF
Switching Characteristics [Note 4]						
Turn-on Delay Time	$t_{d(on)}$	V_{DD}=60V,I_D=60A V_{GS}=10V,R_G=4.7Ω	-	16	-	nS
Turn-on Rise Time	t_r		-	67	-	nS
Turn-Off Delay Time	$t_{d(off)}$		-	45	-	nS
Turn-Off Fall Time	t_f		-	14	-	nS
Total Gate Charge	Q_g	V_{DS}=60V,I_D=60A, V_{GS}=10V	-	84.7	-	nC
Gate-Source Charge	Q_{gs}		-	30.6	-	nC
Gate-Drain Charge	Q_{gd}		-	18.3	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage [Note 3]	V_{SD}	V_{GS}=0V,I_S=129A	-		1.2	V
Diode Forward Current [Note 2]	I_S		-	-	129	A
Reverse Recovery Time	t_{rr}	T_J = 25°C, I_F = I_S di/dt = 100A/μs[Note3]	-	60		nS
Reverse Recovery Charge	Qrr		-	140		nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, t ≤ 10 sec.
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production
5. EAS condition : Tj=25℃,V_{DD}=50V,V_G=10V,L=0.5mH,Rg=25Ω

Test Circuit

1) E$_{AS}$ test Circuit
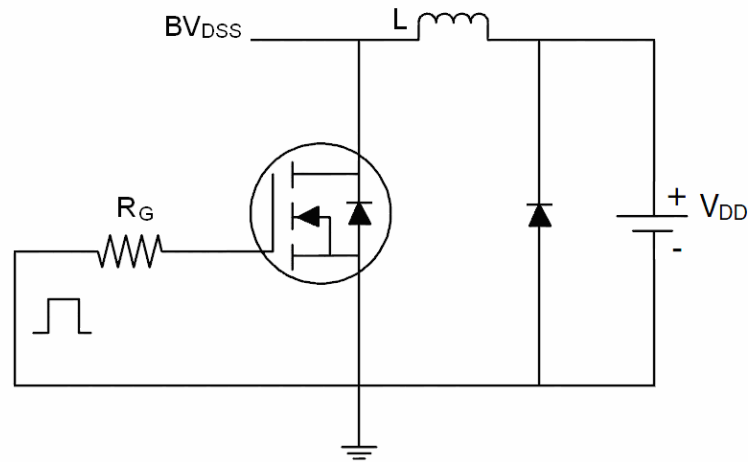
2) Gate charge test Circuit
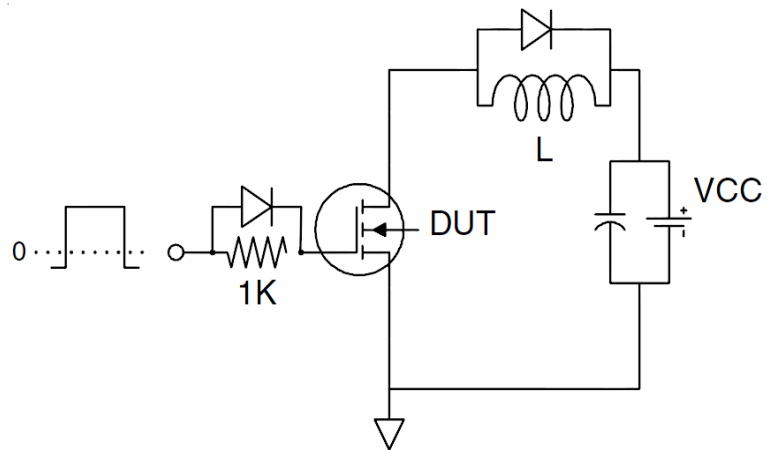
3) Switch Time Test Circuit
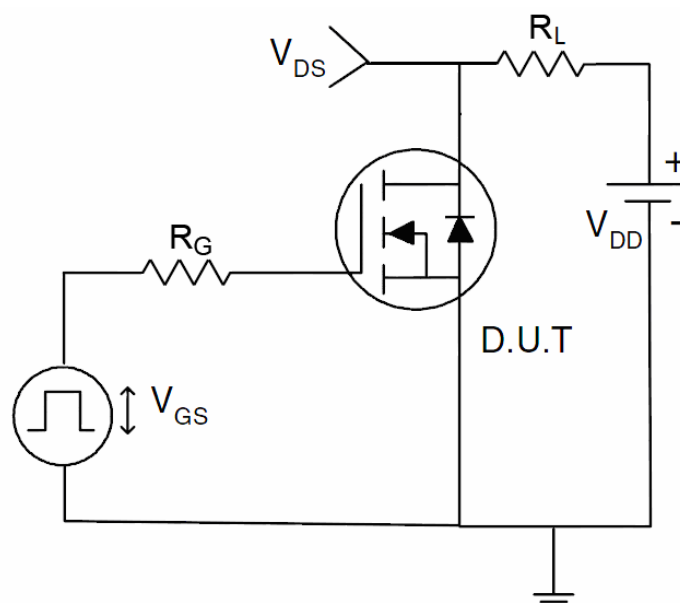
Typical Electrical and Thermal Characteristics
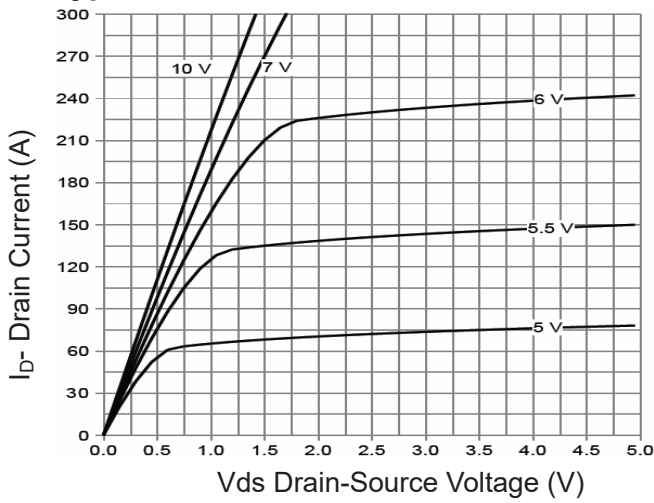
Figure 1 Output Characteristics
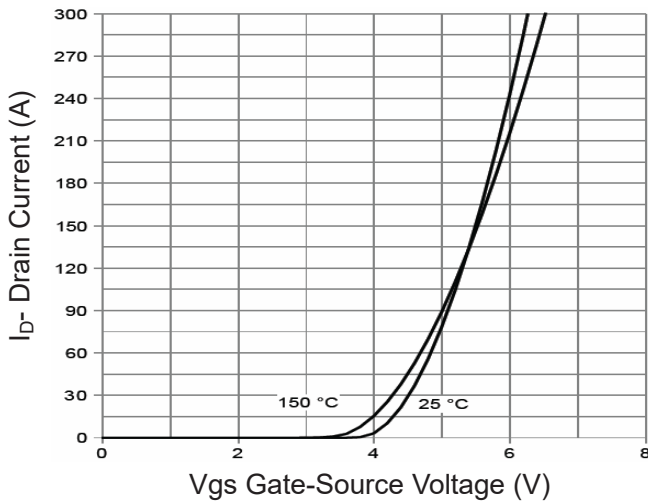
Figure 2 Transfer Characteristics
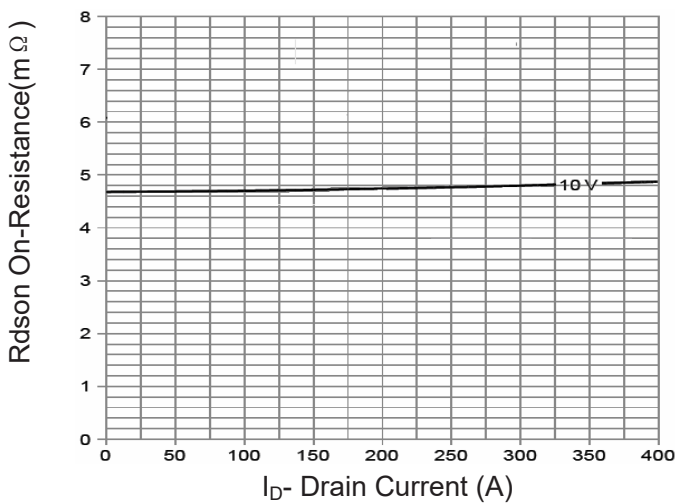
Figure 3 Rdson- Drain Current
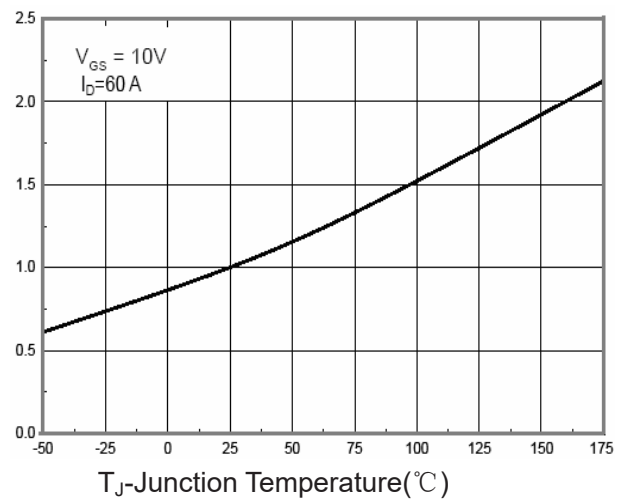
Figure 4 Rdson-JunctionTemperature
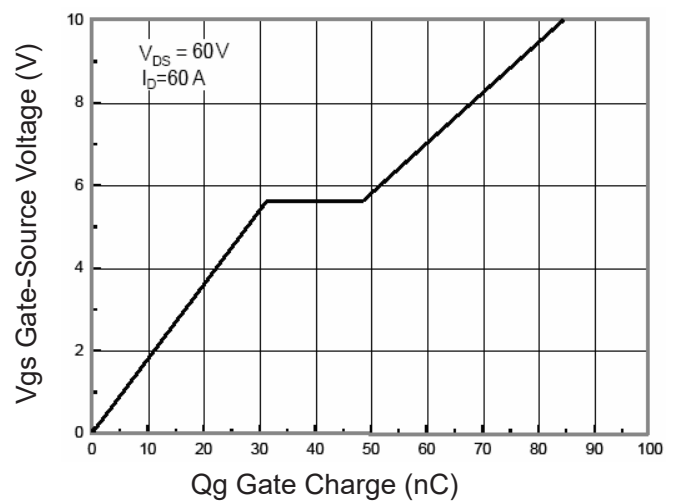
Figure 5 Gate Charge
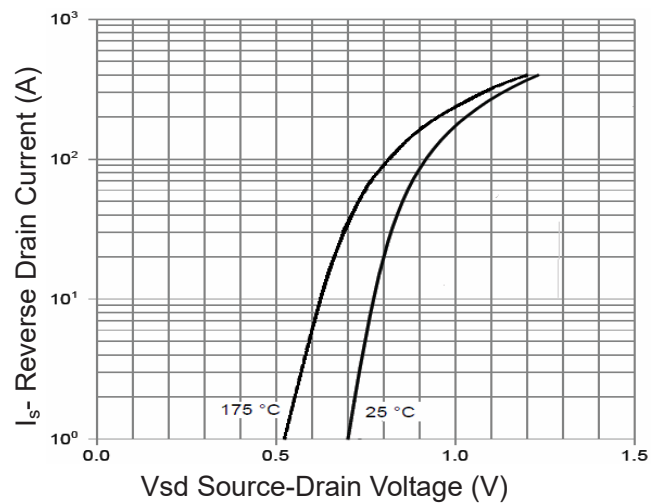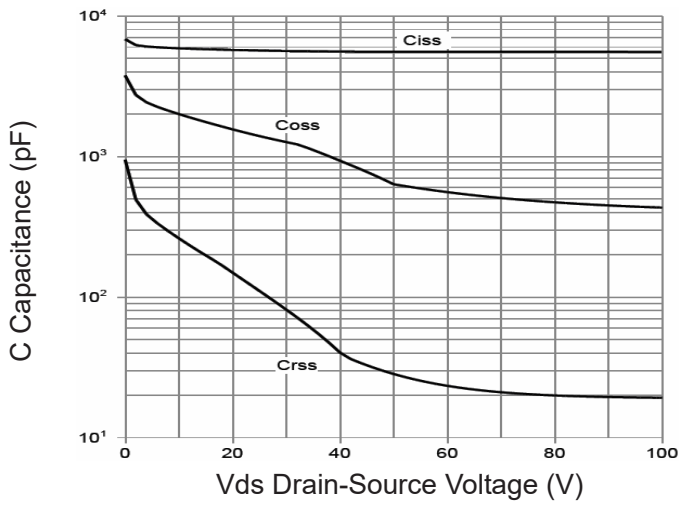

Figure 6 Source- Drain Diode Forward
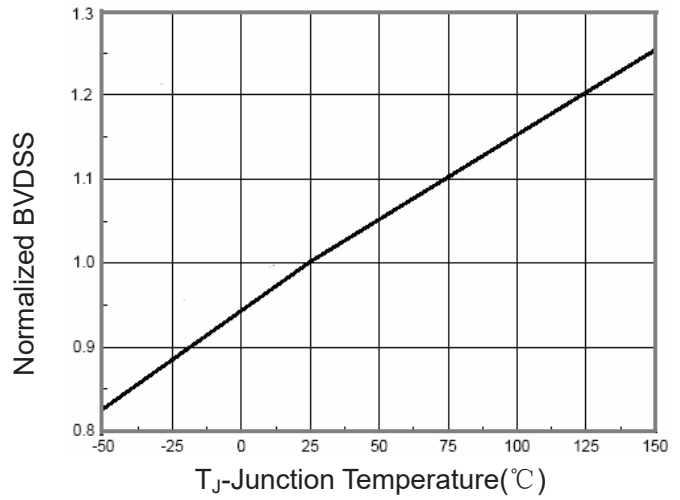
Figure 7 Capacitance vs Vds

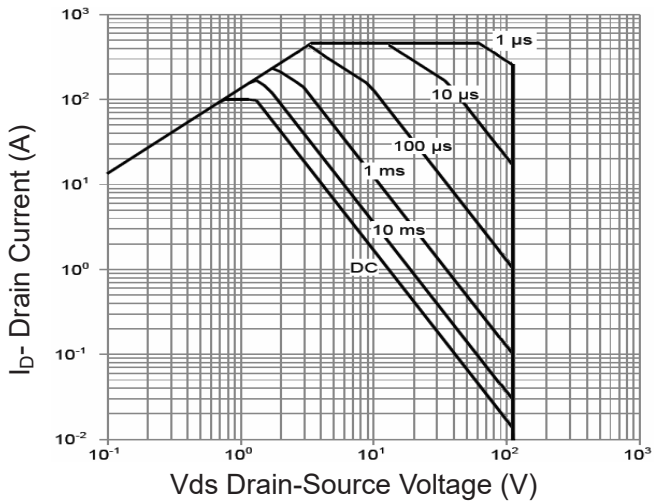**Figure 9 BV$_{DSS}$ vs Junction Temperature**
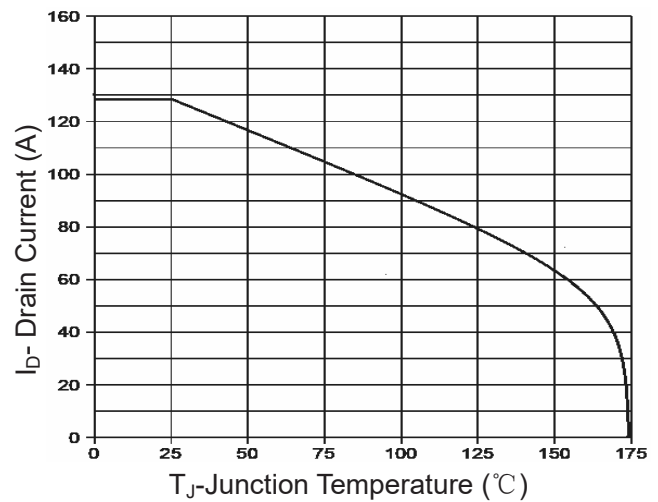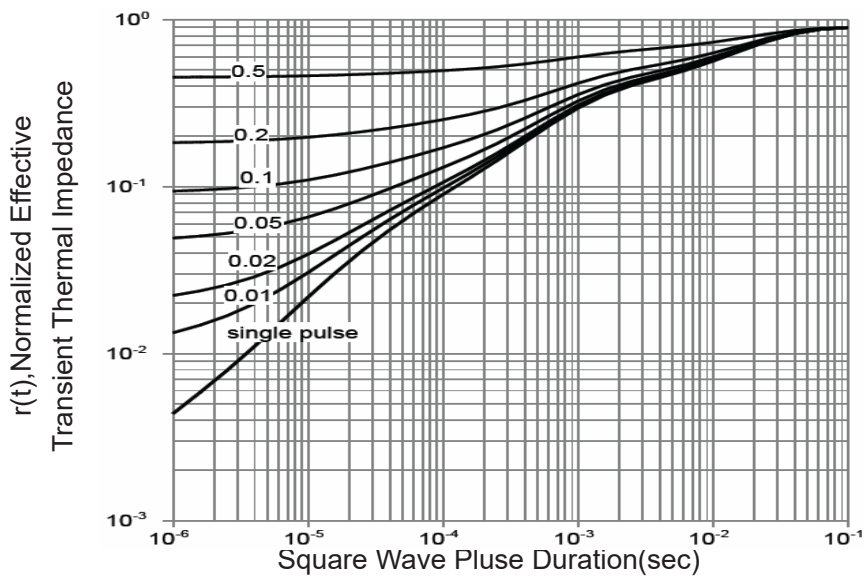
Figure 8 Safe Operation Area

Figure 10 Current De-rating

Figure 11 Normalized Maximum Transient Thermal Impedance